

Search Notes

Application/Control No.

10/796,587

Examiner

John S. Chu

Applicant(s)/Patent under
Reexamination

NAINI ET AL.

Art Unit

1752

SEARCHED

Class	Subclass	Date	Examiner
430	190	11/2005	jsr
430	191		
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528	335,338		
528	339,340		
528	347		
528	348		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Reviewed prosecution history	11/2005	jsr